New method observes compositional fluctuations in high-In-content InGaN LEDs

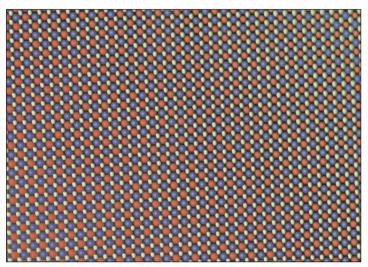
A new method paves the way for developing more efficient LEDs spanning the visible spectrum

he Low Energy Electronic Systems (LEES) Interdisciplinary Research Group (IRG) at Singapore–MIT Alliance for Research and Technology (SMART), together with Massachusetts Institute of Technology (MIT) and the National University of Singapore (NUS), have found a method to quantify the distribution of compositional fluctuations in indium gallium nitride (InGaN) quantum wells (QWs) at different indium concentrations.

InGaN light-emitting diodes have revolutionized solidstate lighting due to their high efficiencies, durability and low cost. The LED emission color can be changed by varying the indium concentration in the InGaN, giving InGaN LEDs the potential to cover the entire visible spectrum. InGaN LEDs with relatively low indium amounts compared to gallium, such as in blue, green and cyan LEDs, have enjoyed significant commercial success for communication, industry and automotive applications. However, LEDs with higher indium concentrations, such as the red and amber LEDs, suffer from a drop in efficiency with the increasing amount of indium.

Red and amber LEDs are currently made using aluminum indium gallium phosphide (AlInGaP) instead of InGaN due to InGaN's poor performance in the red and amber spectrum caused by the efficiency drop. Understanding and overcoming the efficiency drop is the first step towards developing InGaN LEDs covering the whole visible spectrum that would significantly reduce production costs.

In a paper 'Unlocking the origin of compositional fluctuations in InGaN light emitting diodes' (Mishra et al, Physical Review Materials, 5, 024605) the team employed a multi-faceted method — combining electron energy loss spectroscopy (EELS) imaging at subnanometer resolution with multi-scale computational models — to understand the origin of compositional fluctuations and their potential effect on the efficiency of InGaN LEDs. The accurate determination of compositional fluctuations is critical to understanding their role in reducing efficiency in InGaN LEDs with higher indium compositions.



Array of multi-colored LEDs periodically arranged to give off visible light as shown above; a combination of InGaNbased red, blue and green LEDs is essential to cover lighting demands efficiently in the entire visible spectrum. Photo credit: SMART.

"The [origin of the] efficiency drop experienced in higher-indium-concentration InGaN LEDs is still unknown to this date," says co-author professor Silvija Gradecak of the Department of Materials Science and Engineering at NUS and principal investigator at SMART LEES. "It is important to understand this efficiency drop to create solutions that will be able to overcome it. In order to do so, we have designed a method that is able to detect and study the compositional fluctuations in the InGaN QWs to determine its role in the efficiency drop."

The researchers developed a multi-faceted method to detect indium compositional fluctuations in the InGaN QWs using synergistic investigation that combines complementary computational methods, advanced atomic-scale characterization and autonomous algorithms for image processing.

"This method developed and used in our research is of general applicability and can be adapted to other materials science investigations where compositional fluctuations need to be investigated," says Tara Mishra, lead author of the paper and SMART PhD fellow.

"The method that we developed can be widely applied and provide significant value and impact on other materials science studies, where atomistic compositional fluctuations play an important role in material performance," says Dr Pieremanuele Canepa, co-author and principal investigator at SMART LEES and also assistant professor in the Department of Materials Science & Engineering and Department of Chemical & Biomolecular Engineering at NUS. "The understanding of the atomic distribution of InGaN at varying indium concentrations is key to developing next-generation full-color displays using the InGaN LED platform."

The research found that the indium atoms are randomly distributed in a relatively low-indium-content InGaN. On the other hand, partial phase separation is observed in higher-indium-content InGaN, where random compositional fluctuations are concurrent with pockets of indium-rich regions.

The researchers reckon that the findings advance understanding of the atomic microstructure of the InGaN and its potential effect on LED performance, paving the way for future research to determine the role of compositional fluctuations in the new generation of InGaN LEDs and design strategies to prevent the degradation of these devices.

The research is carried out by SMART and supported by the National Research Foundation (NRF) Singapore under its Campus for Research Excellence And Technological Enterprise (CREATE) program. ■

https://doi.org/10.1103/PhysRevMaterials.5.024605 www.circuit-innovation.org

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